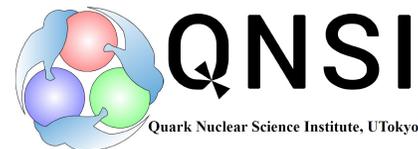


News from Japan

TAKU GUNJI

QUARK-NUCLEAR SCIENCE INSTITUTE, THE UNIVERSITY OF TOKYO

NISHINA CENTER, RIKEN



TOF Japan: Structure & Responsibilities

▶ TOF Japan Organization

- ▶ **Sensor development & QA:** Hiroshima, RIKEN, others
- ▶ **Readout board (based on UCSC):** Tohoku
- ▶ **FPC:** Nara+RIKEN
- ▶ **Integration:** Hiroshima + RIKEN / Tokyo
- ▶ **Simulation & Reconstruction:** Shinshu
- ▶ **DAQ support:** Tokyo, RCNP-Osaka

Budget Situation (Japanese FY2025)

▶ Budget overview

- ▶ RIKEN supplementary budget: ~400M JPY (~2.6M USD)
- ▶ Approximately ~300M JPY (~2M USD) allocated to TOF

▶ Purpose

- ▶ Infrastructure building
- ▶ Real-size strip sensor production
- ▶ Readout and DAQ preparation for R&D in lab. and beamtests
- ▶ Toward integration-level capability

▶ **This was a strategic infrastructure-building year.**

Clean room and assembly environment

▶ New Cleanroom Facilities

- ▶ Hiroshima: ~100 m² (operational from April)
- ▶ RIKEN: ~50 m² (starting June)

▶ Capable of:

- ▶ Sensor QA
- ▶ Wire bonding
- ▶ PCB (stavelet) and FPC mounting (stave)
- ▶ Assembly and prototype integration



Major Infrastructure Investment

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▶ Electronics & Measurement

- ▶ Oscilloscopes: WaveRunner 8208 ×5, WavePro 804HD ×2 (Teledyne Lecroy)
→ Some units to be distributed for sensor QA
- ▶ Source meter units, electrometers, picoammeters
→ To support distributed QA

▶ Assembly Equipment (RIKEN & Hiroshima)

- ▶ (Automatic and Manual) Wire bonders
- ▶ Dispenser x2
- ▶ Bond tester x2
- ▶ Die bonder x2



Major Infrastructure Investment

6

▶ Advanced Characterization

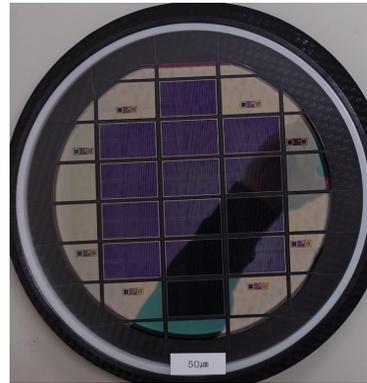
- ▶ Laser & TCT scan systems (RIKEN & Hiroshima)
- ▶ RFSoc digitizer modules (RIKEN, currently 40 ch)
- ▶ CAEN digitizer VME modules (RIKEN)
- ▶ Multi-channel CAEN HV systems (RIKEN & Hiroshima)
- ▶ Digital microscopes (RIKEN & Hiroshima)
- ▶ Substrate processing machine
- ▶ Network analyzer (FPC development)



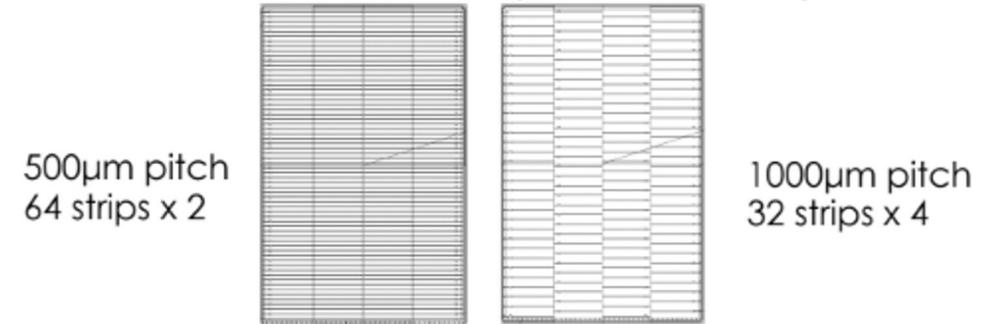
Strip Sensor Production

▶ Baseline sensor 2×3.2 cm²

- ▶ Thickness: 20μm / 30μm / 50μm
- ▶ 500 μm pitch (2 rows)
- ▶ 1000 μm pitch (4 rows, reduced capacitance)
- ▶ Total: 72 sensors

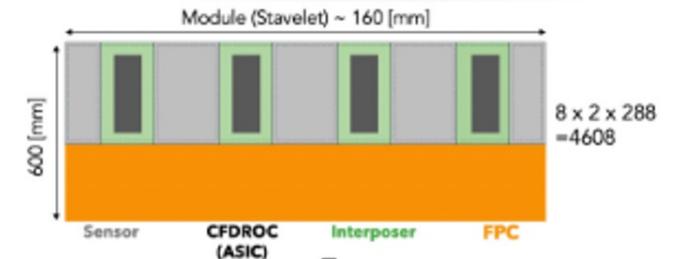


baseline sensor (3.2 cm x 2 cm)



▶ New Baseline Batch (~end of March)

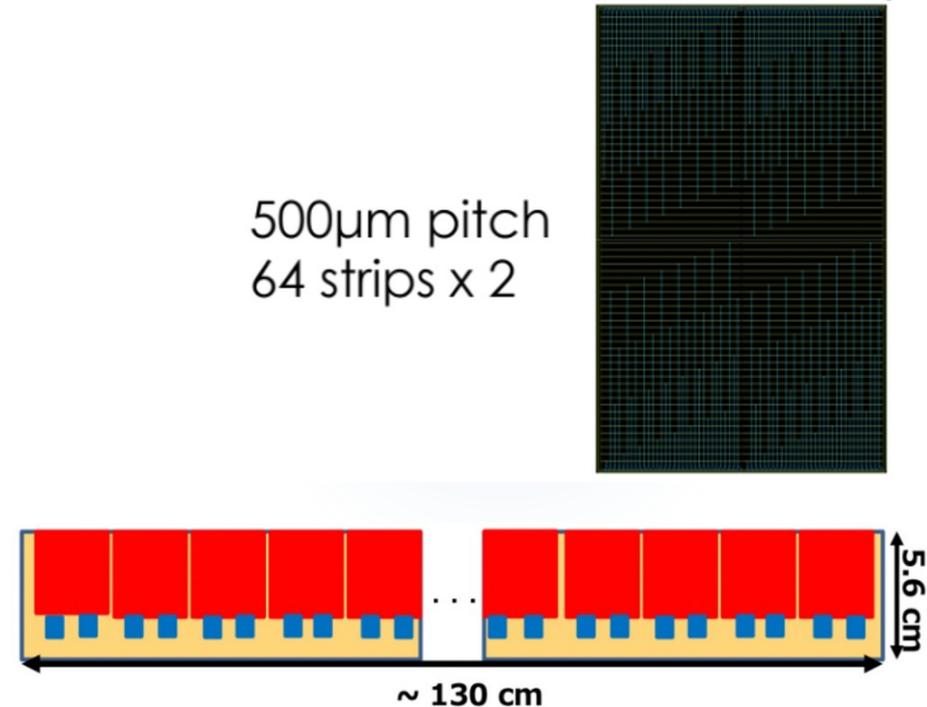
- ▶ 30μm / 50μm
- ▶ 2 rows, 500μm pitch
- ▶ 112 × 2 sensors
- ▶ Shared with RIBF



Strip Sensor Production

8

- ▶ **Double-metal sensors (~ end of March)**
 - ▶ $2 \times 3.2 \text{ cm}^2$, $20/30/50 \mu\text{m}$
 - ▶ 2-row, $500 \mu\text{m}$ pitch (single-side readout) 22×3
 - ▶ 2-row, $500 \mu\text{m}$ pitch (double-side readout) 22×3
 - ▶ 4-row, $1000 \mu\text{m}$ pitch (single-side readout) 22×3
 - ▶ 4-row, $1000 \mu\text{m}$ pitch (double-side readout) 22×3
 - ▶ Shared with RIBF



Test Beam Activities

▶ DESY

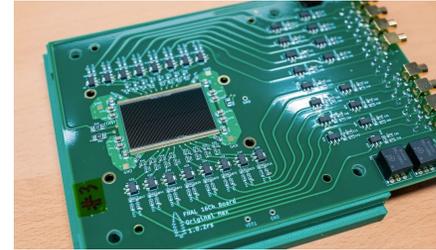
- ▶ 3 strip sensors, 2 pixel sensors, CAEN digitizer

▶ KEK

- ▶ 4 strip sensors + 2 pixel sensors, Scope / RFSoc

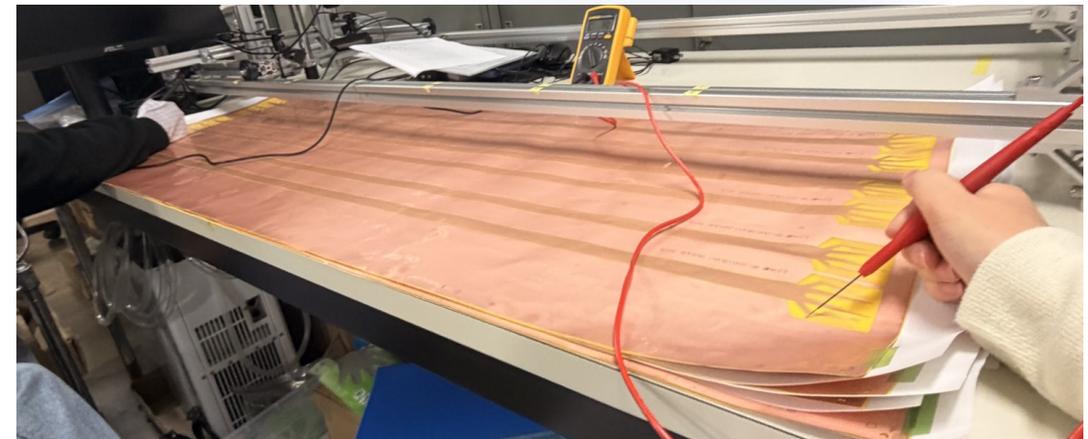
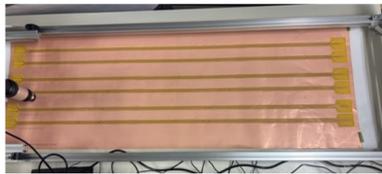
▶ RARiS

- ▶ 5 sensors with scope
- ▶ 3 sensors with QTC + nestDAQ
 - ▶ Japanese SRO DAQ will be tested with AC-LGAD
 - ▶ nestDAQ formats SRO data compatible with EIC reconstruction framework (EICrecon). Online reconstruction under discussion

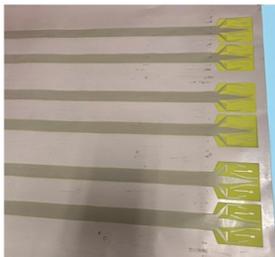


FPC Activities

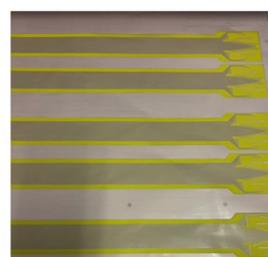
- ▶ Supporting production of long FPC in Korea
 - ▶ First tests ongoing at Nara
- ▶ Contract with company in preparation for simulation and design of FPC



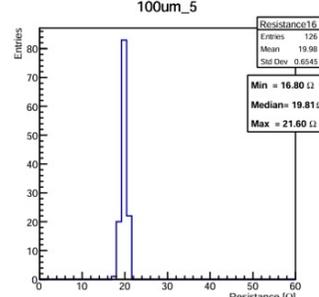
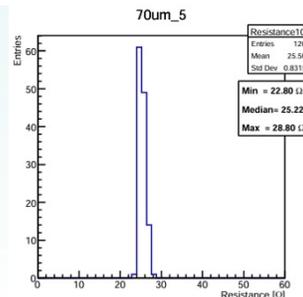
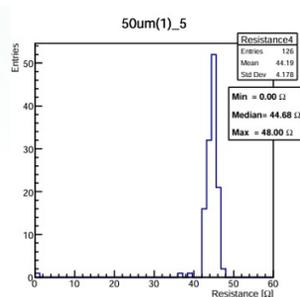
50um



70um



100um



Next JFY's plan

- ▶ **Next year's funding not confirmed yet. Hopefully will come soon.**
- ▶ **Expand capabilities**
 - ▶ Accelerate sensor QA throughput
 - ▶ FPC production and signal integrity
 - ▶ Explore ASIC development path
- ▶ **More Beamtests at KEK and RARiS**
 - ▶ We will support AC-LGAD-wide beamtest activities in Japan. Please contact us!
- ▶ **Move toward integration scale**
 - ▶ **From sensor R&D → stavelet production**
 - ▶ Taiwan collaboration (gantry machine), Synergies with Belle-II
 - ▶ **Start considering QA/QC system for components and stavelets**
 - ▶ **Investment in BNL (Itaru, Rachid)**